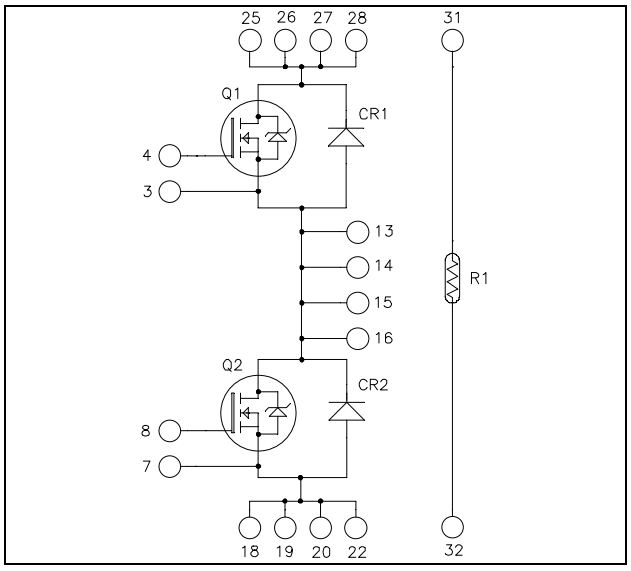
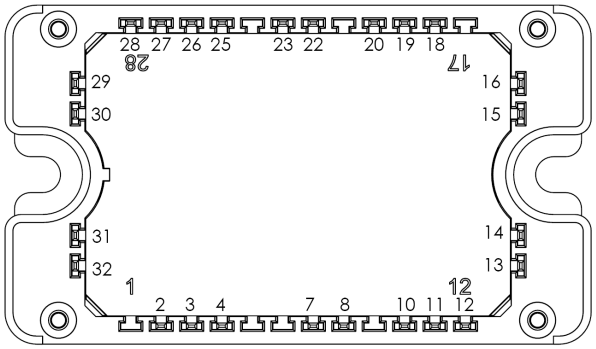
APTMC120AM09CT3AG

Phase leg
SiC MOSFET Power Module

V_{DSS} = 1200V
R_{DSon} = 9mΩ max @ Tj = 25°C
I_D = 295A* @ Tc = 25°C





Pins 25 to 28 must be shorted together
Pins 13 to 16 must be shorted together
Pins 18/19/20/22 must be shorted together

Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

Features

- ***SiC Power MOSFET***
  - High speed switching
  - Low $R_{DS(on)}$
  - Ultra low loss
- ***SiC Schottky Diode***
  - Zero reverse recovery
  - Zero forward recovery
  - Temperature Independent switching behavior
  - Positive temperature coefficient on VF
- Very low stray inductance
- Kelvin source for easy drive
- Internal thermistor for temperature monitoring
- High level of integration
- AlN substrate for improved thermal performance

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

All ratings @ T_j = 25°C unless otherwise specified

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.
See application note APT0502 on www.microsemi.com

Absolute maximum ratings (per SiC MOSFET)

Symbol	Parameter		Max ratings	Unit
V_{DSS}	Drain - Source Voltage		1200	V
I_D	Continuous Drain Current	T_c = 25°C	295*	A
		T_c = 80°C	220*	
I_{DM}	Pulsed Drain current		590	
V_{GS}	Gate - Source Voltage		-10/25V	V
R_{DSon}	Drain - Source ON Resistance		9	mΩ
P_D	Maximum Power Dissipation	T_c = 25°C	1250	W

* Specification of device but current must be limited due to size of pins.

Electrical Characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	V_{GS} = 0V , V_{DS} = 1200V				400	µA
$R_{DS(on)}$	Drain – Source on Resistance	V_{GS} = 20V, I_D = 200A	T_j = 25°C		6.25	9	mΩ
			T_j = 150°C		11	16	
$V_{GS(th)}$	Gate Threshold Voltage	V_{GS} = V_{DS}, I_D = 40mA		2.1	2.4		V
I_{GSS}	Gate – Source Leakage Current	V_{GS} = 20 V, V_{DS} = 0V				2.4	µA

Dynamic Characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
C_{iss}	Input Capacitance	V_{GS} = 0V V_{DS} = 1000V f = 1MHz			11		nF
C_{oss}	Output Capacitance				0.88		
C_{rss}	Reverse Transfer Capacitance				0.06		
Q_g	Total gate Charge	V_{GS} = -5/+20V V_{Bus} = 800V I_D = 200A			644		nC
Q_{gs}	Gate – Source Charge				184		
Q_{gd}	Gate – Drain Charge				200		
$T_{d(on)}$	Turn-on Delay Time	V_{GS} = -5/+20V V_{Bus} = 800V I_D =200A ; T_J =150°C R_L = 4Ω ; R_{Gext} = 5Ω			35		ns
T_r	Rise Time				40		
$T_{d(off)}$	Turn-off Delay Time				150		
T_f	Fall Time				70		
E_{on}	Turn on Energy	Inductive Switching V_{GS} = -5/+20V V_{Bus} = 600V I_D = 200A R_{Gext} = 5Ω	T_j = 150°C		4.4		mJ
E_{off}	Turn off Energy		T_j = 150°C		2.4		
R_{Gint}	Internal gate resistance				1.5		Ω
R_{thJC}	Junction to Case Thermal Resistance					0.1	°C/W

Body diode ratings and characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V_{SD}	Diode Forward Voltage	V_{GS} = -5V, I_{SD} = 100A		3.3		V
		V_{GS} = -2V, I_{SD} = 100A		3.1		
t_{rr}	Reverse Recovery Time	I_{SD} = 200A ; V_{GS} = -5V V_R = 800V ; di_F/dt = 4000A/µs		45		ns
Q_{rr}	Reverse Recovery Charge			1.62		µC
I_{rr}	Reverse Recovery Current			54		A

SiC schottky diode ratings and characteristics (per SiC diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Peak Repetitive Reverse Voltage					1200	V
I_{RRM}	Reverse Leakage Current	V_R=1200V	T_j = 25°C		140	800	µA
			T_j = 175°C		260	1600	
I_F	DC Forward Current		Tc = 125°C		80		A
V_F	Diode Forward Voltage	I_F = 80A	T_j = 25°C		1.5	1.8	V
			T_j = 175°C		2.2	3	
Q_C	Total Capacitive Charge	I_F = 80A, V_R = 1200V di/dt =2000A/µs			520		nC
C	Total Capacitance	f = 1MHz, V_R = 400V			372		pF
		f = 1MHz, V_R = 800V			268		
R_{thJC}	Junction to Case Thermal Resistance					0.28	°C/W

Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

Symbol	Characteristic		Min	Typ	Max	Unit
R_{25}	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	T_{25} = 298.15 K			3952		K
ΔB/B		T_C=100°C		4		%

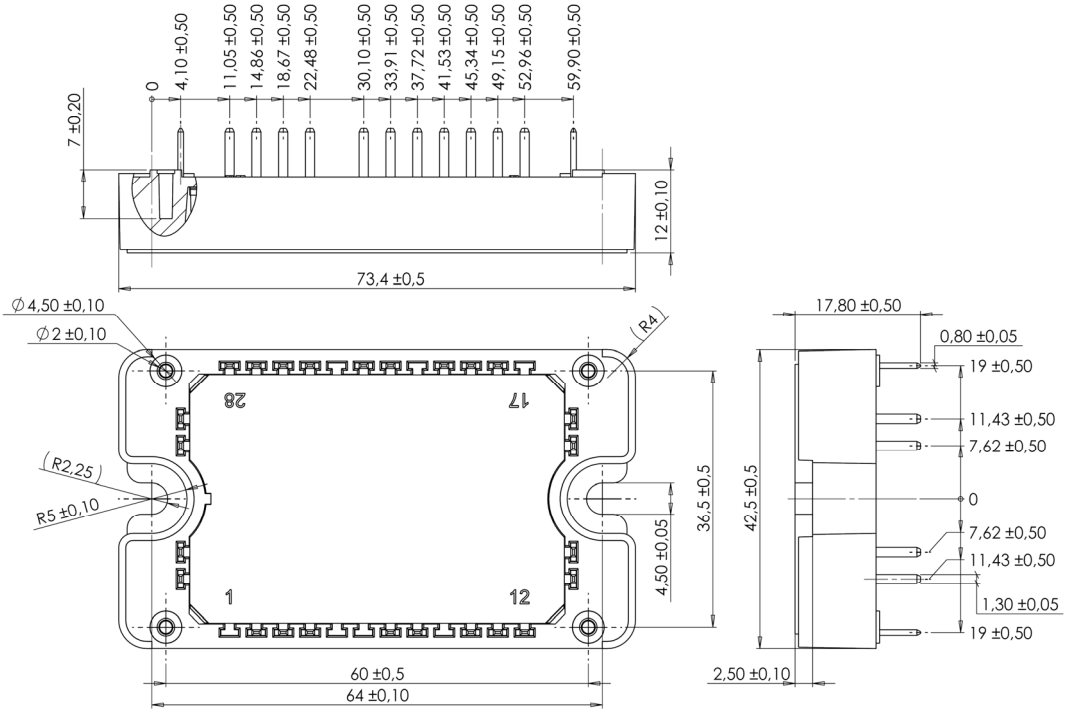
$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

T: Thermistor temperature
R_T: Thermistor value at T

Thermal and package characteristics

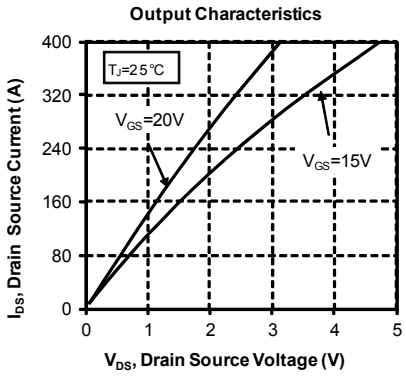
Symbol	Characteristic			Min	Max	Unit
V_{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000		V
T_J	Operating junction temperature range	SiC MOSFET		-40	150	°C
		SiC diode		-40	175	
T_{JOP}	Recommended junction temperature under switching conditions			-40	$T_J$max -25	
T_{STG}	Storage Temperature Range			-40	125	
T_C	Operating Case Temperature			-40	100	
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				110	g

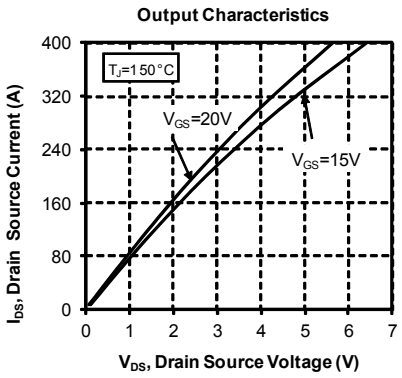
Package outline (dimensions in mm)

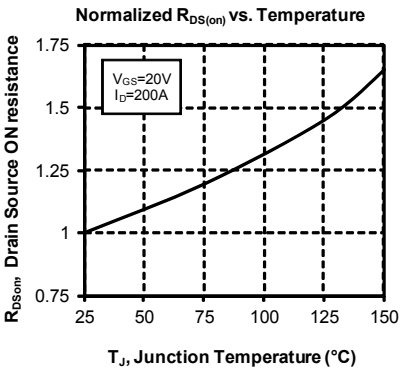


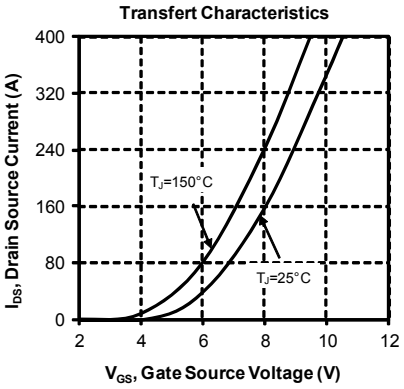
See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com

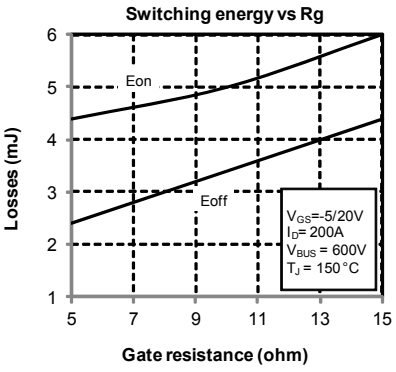
Typical SiC MOSFET Performance Curve

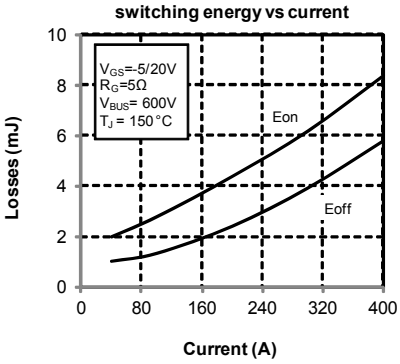


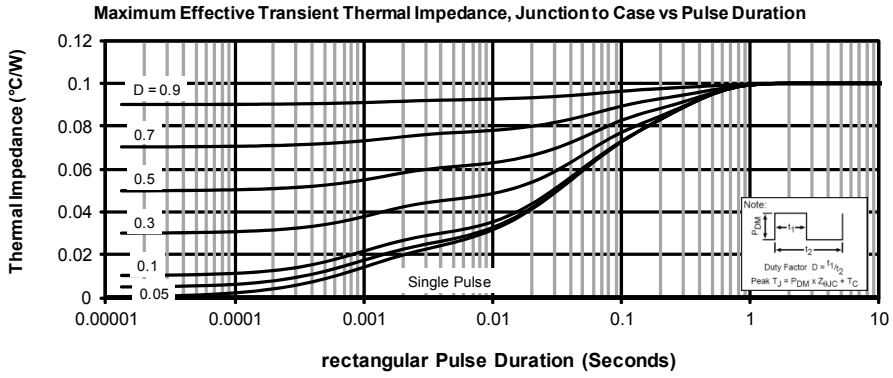




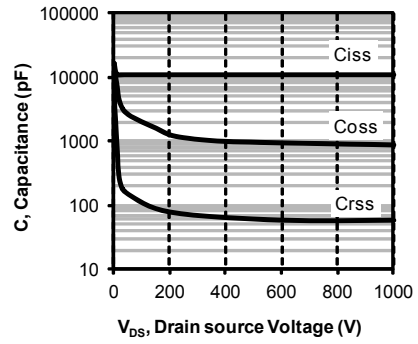




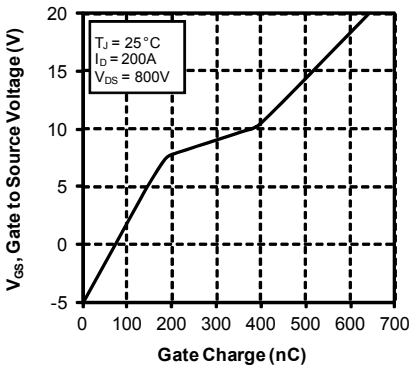




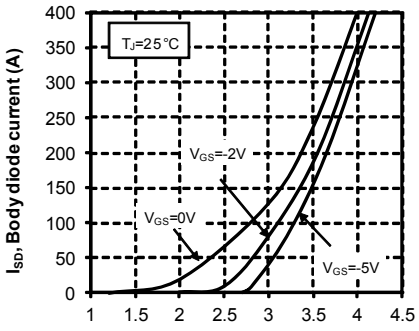
Capacitance vs Drain Source Voltage



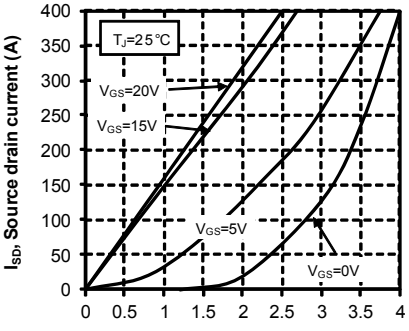
Gate Charge vs Gate Source Voltage



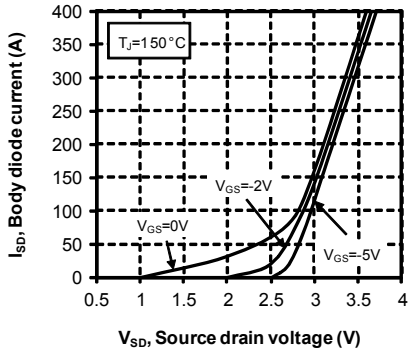
Body diode Characteristics



Output Characteristics



Body diode Characteristics



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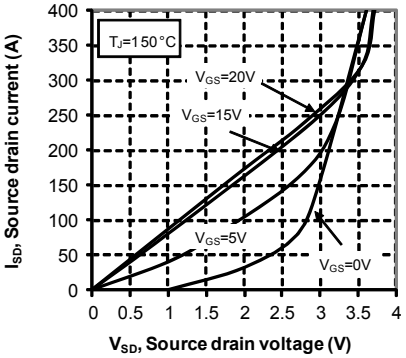
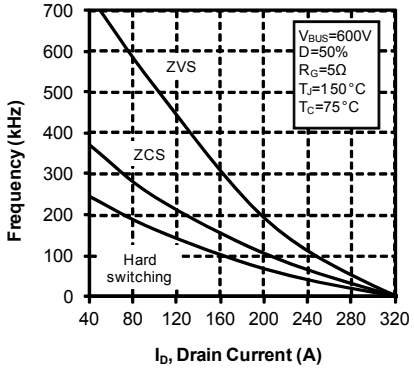
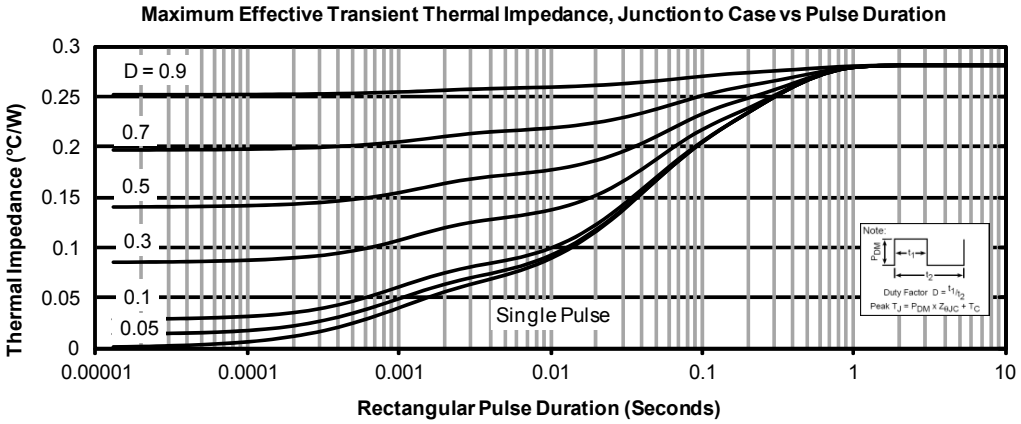
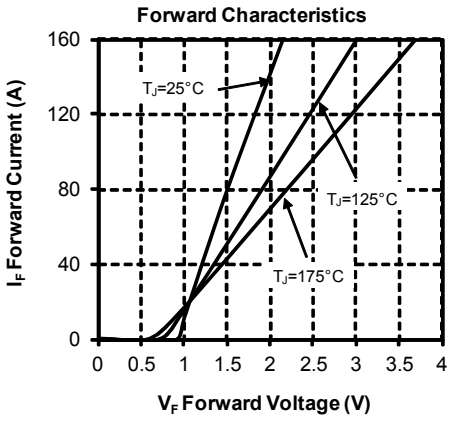


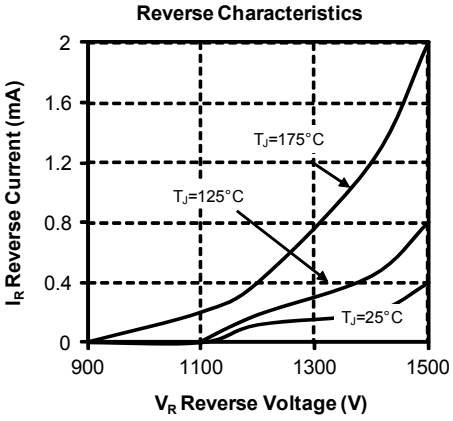
Operating Frequency vs Drain Current

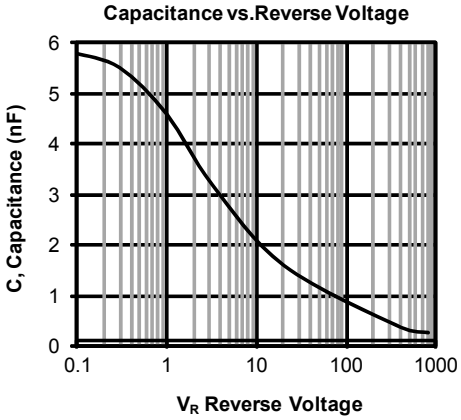


Typical SiC diode Performance Curve









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